



Synthesis and spectroscopic properties of Er³⁺-doped CaF₂ nanocrystals in transparent oxyfluoride tellurite glass–ceramics

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ABSTRACT

Transparent glass–ceramics in TeO₂–SiO₂–AlF₃–CaO–NaF–ErF₃ system were prepared. Effect of heat-treatment schedules on crystallization behavior and microstructure were analyzed by differential scanning calorimetry, X-ray diffraction, infrared spectrum and scanning electron microscopy. The sole CaF₂ nanocrystal phase was confirmed, grains were spherical and distributed uniformly. Te and Si atoms existed in [TeO₃] and [SiO₄] forms. The full width at half maximum at 1533 nm emission increased from 39.16 nm to 43.37 nm after crystallization. Er³⁺ ions were incorporated into CaF₂ nanocrystals with low phonon energies. The transmittance of glass–ceramics reached 78% at 780 nm and 90% at 1017 nm.

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1. Introduction

Er³⁺-doped glass and glass–ceramics are playing important role as lasers and optical amplifiers [1–4]. Oxyfluoride tellurite glass–ceramics is an ideal optical matrix material, it also has some advantages, such as low phonon energy (maximum phonon energy ~750 cm⁻¹, and borate ~1400 cm⁻¹, silicate ~1100 cm⁻¹ and phosphates ~1300 cm⁻¹), the high up-conversion efficiency and low melting temperature, high optical transmittance, high refractive index and so on [5–7]. Rare earth-doped oxyfluoride glass–ceramics has become one of the hot spot in optical materials research.

Since 1991, Komatsu et al. [8] had first prepared tellurite glass–ceramics containing nanocrystals, the oxyfluoride tellurite glass–ceramics has made great strides. Yu et al. [9], Pan et al. [10], Gang et al. [11] and Tatar et al. [12] prepared oxyfluoride tellurite glass–ceramics containing nanocrystals and studied their crystallization properties, thermal stability and optical properties. But oxyfluoride tellurite glass precursor generally contained PbF₂ or CdF₂ in order to widen the glass forming regions, which are harmful to environment and human. In addition, it is difficult for oxyfluoride tellurite glass–ceramics to reach high transparency, because tellurite glass devitrify easily. Consequently, oxyfluoride tellurite glass–ceramics without PbF₂, CdF₂ and Pb_{1-x}Cd_xF₂ nanocrystals have been less reported.

In this work, Er³⁺-doped transparent oxyfluoride tellurite glass without Pb, Cd elements was prepared by melt-annealing, and transparent oxyfluoride tellurite glass–ceramics containing CaF₂ nanocrystals was obtained by subsequent controlled heat-treatment process. Er³⁺-doped oxyfluoride tellurite glass–ceramics is a kind of ideal matrix materials in luminescence field.

2. Experimental

2.1. Preparation

Glass composition (mol%): 32TeO₂–15SiO₂–28AlF₃–15CaO–10NaF–1.5ErF₃, TeO₂ and ErF₃ are high-purity, NaF, SiO₂ and CaO are analytically pure. AlF₃ is chemical pure. The batch were fully mixed and then melted in a platinum crucible with a lid at 850 °C for 30 min in air, and then heated up to 1000 °C for homogenization and clarification in the silicon carbide rod electrical resistance heating furnace, the melt was poured on a stainless steel plate at 300 °C to shape, subsequently moved immediately to the furnace and annealed at 350 °C for 3 h to relieve internal stress, and then cooled down to the room temperature at the furnace. Finally, clear, transparent and bubble-free glass was obtained, marked A. The precursor glass and glass–ceramics samples were mechanically polished to a mirror finish with CeO₂ powders.

2.2. Characterization

Thermal property of the precursor glass was measured by differential scanning calorimeter (DSC, NETZSCH STA 409 C/CD, Germany) from room temperature to 850 °C at a heating rate of 10 °C/min, N₂ atmosphere. An X-ray powder diffraction system (D/max 2550HB+/PC, Rigaku, Japan) with CuKα radiation (0.154056 nm) was used for identification of the crystal phase, at 50 kV and 300 mA, the 2θ scanning range was 15°–85° at a rate of 4°/min. Field emission scanning electron microscope (S-4800FESEM, Hitachi, Japan) was used to study the glass–ceramics morphology, the grain size and distribution in the residual glass matrix. The network structure of glass and glass–ceramics were confirmed by Fourier infrared

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Table 1
Heat-treatment schedules and appearance.

No.	Nucleation temperature/°C	Nucleation time/h	Crystallization temperature/°C	Crystallization time/h	Appearance
B	370	4	420	6	Transparent
C	370	4	420	8	Translucent
D			430	10	Opaque

spectrometer (FT-IR, model IFS55, BRUKER, Germany) with resolution of 4 cm^{-1} over the range of $4000\text{--}400\text{ cm}^{-1}$ at room temperature. Transmittance of the precursor glass and glass-ceramics were measured by UV-Vis scanning spectrophotometer (UVmini1240, Japan). The fluorescence spectra were obtained with an UV-Vis-IR spectrofluorimeter (Fluorolog-3, HORIBA-JOBINYVON, France) under the excitation of 980 nm LD. The InAs detector worked at liquid nitrogen temperature.

3. Results and discussion

3.1. Thermal property

The glass transition temperature T_g , crystallization initial temperature T_x and crystallization peak temperature T_c are determined 370°C , 410°C and 440°C , respectively according to the DSC curve in Fig. 1. Various heat treatment processes are established and given in Table 1.

3.2. Crystal phase composition, microstructure and morphology

X-ray diffraction (XRD) patterns of oxyfluoride tellurite glass and glass-ceramics are shown in Fig. 2. It can be seen from Fig. 2 that there is only halo patterns without any sharp peaks are observed in curve A, it is confirmed that sample A is amorphous glass. Obvious crystallization peaks can be observed in B, C and D curves, all the peaks are analyzed with the standard sample spectra JSPDF (03-065-0535), the sole crystal phase CaF_2 is identified. It is noted that the intensity of CaF_2 crystal phase becomes larger with the increase of the heat-treatment temperature and time duration. However, the XRD peak positions of CaF_2 nanocrystals formed by the crystallization in precursor glass A shift towards lower diffraction angles compared with CaF_2 bulk crystals standard sample. According to the Bragg's law, diffraction angles shifting towards left indicates that interplanar crystal spacing increases. Considering the ionic radii, r , of Ca^{2+} ($r = 0.100\text{ nm}$) and Er^{3+} ($r = 0.089\text{ nm}$), and Ca^{2+} ions are cubic close packing in CaF_2 unit cell, the lattice spacing should decrease if smaller Er^{3+} ions replaced larger Ca^{2+} ions, while the interplanar crystal spacing increases according to the results of XRD analysis, so the incorporation of Er^{3+} ions into the octahedral interstice of CaF_2 nanocrystals is suggested.

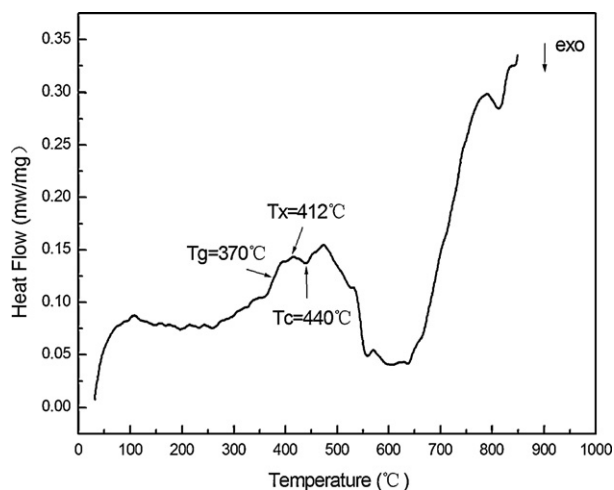


Fig. 1. DSC curve of the oxyfluoride tellurite precursor glass.

FESEM photograph of oxyfluoride tellurite glass-ceramics B is shown in Fig. 3. The spherical CaF_2 nanocrystals embed homogeneously among the glassy matrix after crystallization. The grain size of sample B is about 45 nm. Sample B is transparent, which could be proved by the transmittance curve in Section 3.4.

3.3. Glass and glass-ceramics network structure

Infrared absorption spectra of the transparent oxyfluoride tellurite glass and glass-ceramics are shown in Fig. 4. The strong absorption peaks can be seen at around 450 cm^{-1} , 560 cm^{-1} , 750 cm^{-1} , 1018 cm^{-1} , 1640 cm^{-1} and 3440 cm^{-1} in glass and glass-ceramics IR spectra.

Absorption peaks at 450 cm^{-1} are contributed to the O-Si-O bonds bending vibration, absorption peaks at 570 cm^{-1} are contributed to the Al-O-Al bonds bending vibration of $[\text{AlO}_6]$

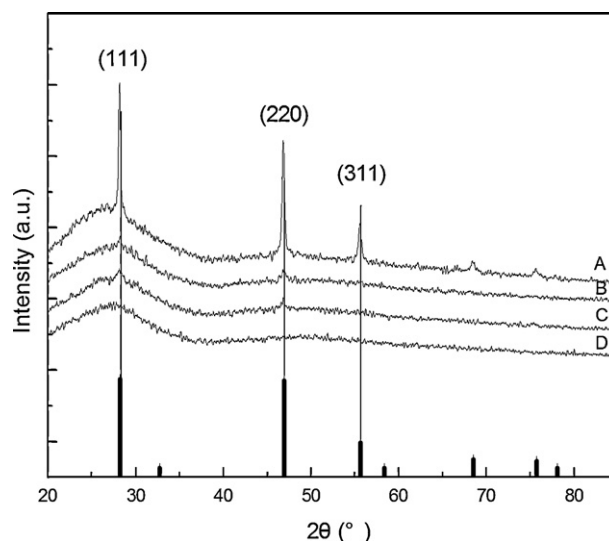


Fig. 2. XRD patterns of oxyfluoride tellurite precursor glass and glass-ceramics.

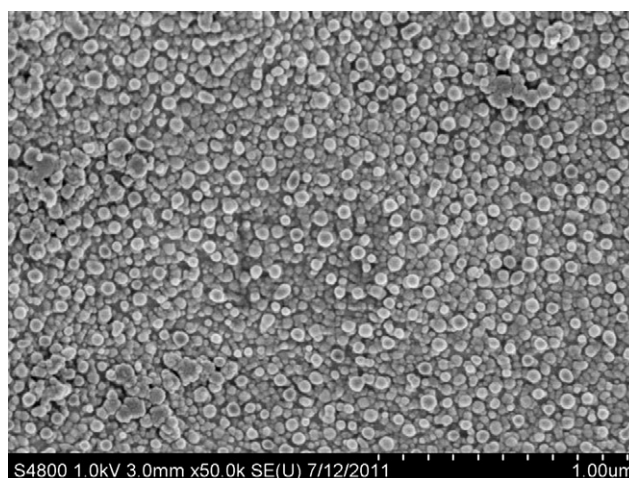


Fig. 3. FESEM photographs of glass-ceramics.

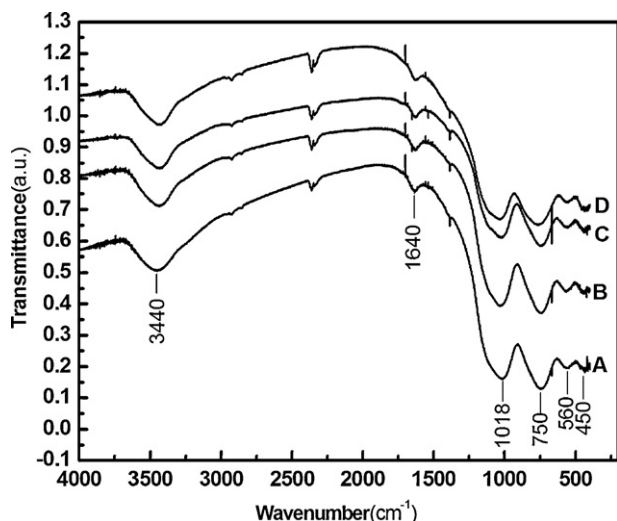


Fig. 4. Infrared spectra of oxyfluoride tellurite precursor glass and glass-ceramics.

octahedron. Absorption peaks at 750 cm^{-1} are contributed to the stretching vibration of Te–O bonds in the $[\text{TeO}_3]$ triangular pyramid structure. The introduction of fluorine in the oxyfluoride tellurite glass would make Te–O bonds fracture of O–Te–O in $[\text{TeO}_4]$ double triangular pyramids, and convert to $[\text{TeO}_3]$ triangular pyramids. The absorption peak at 620 cm^{-1} is not obvious, which indicates that there is less $[\text{TeO}_4]$ double triangular pyramid in glass matrix.

The absorption peaks at 1018 cm^{-1} correspond to the Si–O–Al bond asymmetric stretching vibration, the atomic radii of Al and Si are similar, so Al atoms replace Si atoms to form $[\text{AlO}_4]$ tetrahedron, Al atoms act as glass forming body to strengthen glass network structure.

Obvious infrared absorption peaks at 1640 cm^{-1} and 3440 cm^{-1} corresponds to the vibration of H_2O and –OH groups. Absorption peaks of H_2O and –OH groups are mainly due to crystal water contained in AlF_3 raw materials and without any atmosphere protection during melting.

Compared with the infrared absorption peaks of oxyfluoride tellurite glass, glass-ceramics has no remarkable difference, which indicates that the crystallization process has no markedly effect on the glass matrix network structure.

3.4. Glass and glass-ceramics transmittance

The transmittance spectra of Er^{3+} -doped precursor glass and transparent glass-ceramics B are shown in Fig. 5. The obvious absorption peaks can be seen at 975, 798, 652, 540, 520, 489 and 451 nm, corresponding to the transitions from the ground state $^4I_{15/2}$ to the excited states $^4I_{11/2}$, $^4I_{9/2}$, $^4F_{9/2}$, $^4S_{3/2}$, $^2H_{11/2}$, $^4F_{7/2}$ and $^4F_{5/2}$ of Er^{3+} ions, respectively. The transmittance of glass-ceramics can reach 78% at 780 nm and 90% at 1017 nm.

3.5. Glass and glass-ceramics fluorescence spectra

Fig. 6 shows the fluorescence spectra of precursor glass and transparent glass-ceramics B in the range of 1000–1600 nm. The broad emission band of the Er^{3+} ions corresponds to the $^4I_{13/2} \rightarrow ^4I_{15/2}$ transition at 1533 nm. The FWHM (full width at half maximum) of this emission band increases from 39.16 nm to 43.37 nm after crystallization. And the relative fluorescence intensity at 1553 nm increases obviously as well. Er^{3+} ions in the oxyfluoride glass are mainly coupled to the non-bridging oxygen on the O–Te and/or O–Si (Al) bonds with relatively high phonon

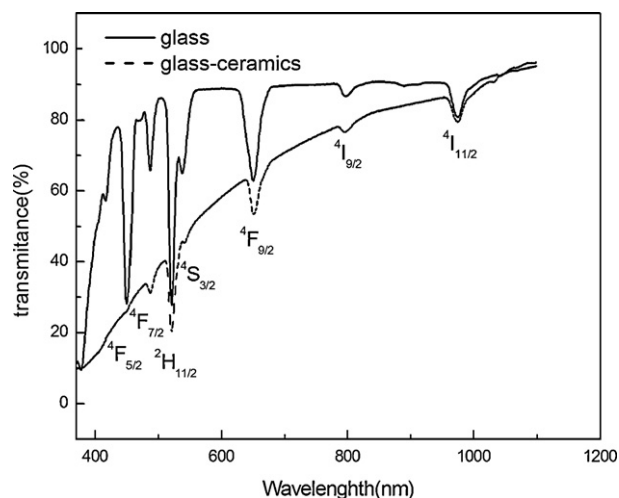


Fig. 5. Transmittance spectra of Er^{3+} -doped precursor glass and glass-ceramics.

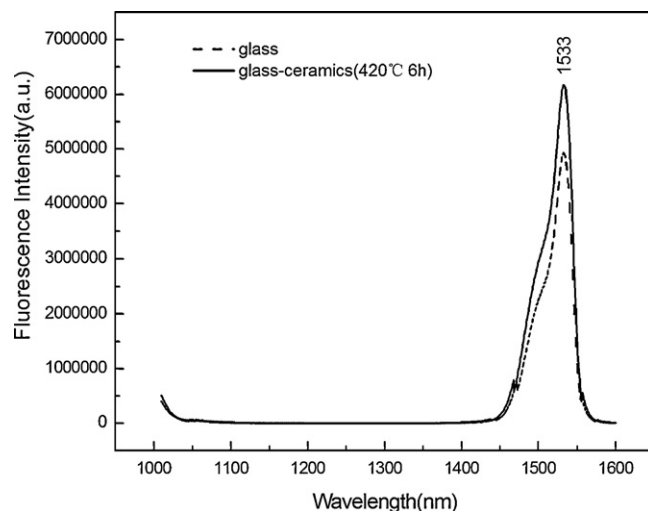


Fig. 6. Fluorescence spectra of Er^{3+} -doped precursor glass and glass-ceramics under 980 nm excitation.

energies, while in oxyfluoride glass-ceramics Er^{3+} ions are incorporated into CaF_2 nanocrystals with low phonon energies.

4. Conclusions

Er^{3+} -doped oxyfluoride tellurite glass $32\text{TeO}_2\text{--}15\text{SiO}_2\text{--}28\text{AlF}_3\text{--}15\text{CaO--}10\text{NaF}$ was prepared successfully, and the transparent oxyfluoride glass-ceramics containing CaF_2 nanocrystals was obtained by controlled heat-treatment at 370°C nucleation for 4 h and at 420°C crystallization for 6 h. CaF_2 nanocrystals sized at 45 nm are spherical and embed homogeneously among the glassy matrix. Te and Si atoms exist in $[\text{TeO}_3]$ and $[\text{SiO}_4]$ forms. Part of Al atoms exists in the forms of $[\text{AlO}_4]$ and form network together with $[\text{SiO}_4]$ tetrahedron. The other Al atoms exist in the forms of $[\text{AlO}_6]$ as modifiers. The transmittance of glass-ceramics can reach 78% at 780 nm and 90% at 1017 nm. The broad emission band of the Er^{3+} ions corresponds to the $^4I_{13/2} \rightarrow ^4I_{15/2}$ transition at 1533 nm. The FWHM of this emission band increases from 39.16 nm to 43.37 nm after crystallization. Er^{3+} ions are incorporated into CaF_2 nanocrystals with low phonon energies.

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